Se	arch No	ites

Application/Control No.	Applicant(s)/Patent und Reexamination	er
10/790,196	NIIMI, AKIKO	
Examiner	Art Unit	
LAM S. NGUYEN	2853	

SEARCHED			
Class	Subclass	Date	Examiner
347	2, 101, 102, 103, 104, 171	6/21/2006	LN
347	4,5	11/20/07	W
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		11/20/0	7
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
347	104,2,4	11/20/07	LN
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST (PGPUB, USPAT, EPO, JPO, DERWENT, IBM) Search note print out	6/21/2006	LN		
EAST (PEPUB, USPAT, EPO, JPO, DEEWENT, DBM) Scarch note protunt	1120/07	W		